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Docket No.: 4684-010

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Inventor(s): Heui-Jae PAHK et al.

Confirmation No. 2498

U.S. Patent Application No. 10/501,381

Group Art Unit: 2877

Filed: July 15, 2004

Examiner:

For:

MACHINE AND METHOD FOR INSPECTING FERRULE OF OPTICAL

CONNECTOR

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

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Date: November 17, 2004

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

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APPLICANT

Heui-Jae PAHK et al.

FILING DATE
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GROUP 2877

FILING **EXAMINER'S CLASS SUBCLASS** NAME PATENT NO. DATE **INITIALS** DATE FOREIGN PATENT DOCUMENTS Translation **EXAMINER'S** DATE COUNTRY **CLASS SUBCLASS** PATENT NO. Yes **INITIALS** \mathbf{X} 1999-025138 4/1999 Korea X 08-029642 2/1996 Japan X 61-221632 10/1986 Japan Korea X 00269263 7/2000

U.S. PATENT DOCUMENTS

EXAMINER DATE CONSIDERED

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

3/1999

00198817

Korea

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.